

# SEMiX402GB066HDs



## SEMiX<sup>®</sup>2s

### Trench IGBT Modules

SEMiX402GB066HDs

Preliminary Data

#### Features

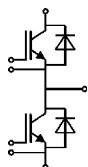
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- UL recognised file no. E63532

#### Typical Applications

- Matrix Converter
- Resonant Inverter
- Current Source Inverter

#### Remarks

- Case temperature limited to  $T_C=125^\circ\text{C}$  max.
- Product reliability results are valid for  $T_j=150^\circ\text{C}$
- For short circuit: Soft  $R_{Goff}$  recommended
- Take care of over-voltage caused by stray inductance



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Absolute Maximum Ratings					
Symbol	Conditions		Values	Unit	
<b>IGBT</b>					
$V_{CES}$			600	V	
$I_C$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	509	A	
		$T_c = 80^\circ\text{C}$	383	A	
$I_{Cnom}$			400	A	
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$		800	A	
$V_{GES}$			-20 ... 20	V	
$t_{psc}$	$V_{CC} = 360\text{ V}$ $V_{GE} \leq 15\text{ V}$ $T_j = 150^\circ\text{C}$ $V_{CES} \leq 600\text{ V}$			6	$\mu\text{s}$
$T_j$			-40 ... 175	$^\circ\text{C}$	
<b>Inverse diode</b>					
$I_F$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	543	A	
		$T_c = 80^\circ\text{C}$	397	A	
$I_{Fnom}$			400	A	
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$		800	A	
$I_{FSM}$	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		1800	A	
$T_j$			-40 ... 175	$^\circ\text{C}$	
<b>Module</b>					
$I_{t(RMS)}$			600	A	
$T_{stg}$			-40 ... 125	$^\circ\text{C}$	
$V_{isol}$	AC sinus 50Hz, $t = 1\text{ min}$		4000	V	

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>IGBT</b>						
$V_{CE(sat)}$	$I_C = 400\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.45	1.9		V
		$T_j = 150^\circ\text{C}$	1.70	2.1		V
$V_{CE0}$						
	$T_j = 25^\circ\text{C}$		0.9	1		V
	$T_j = 150^\circ\text{C}$		0.85	0.9		V
$r_{CE}$	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$	1.4	2.3		$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	2.1	3.0		$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE}=V_{CE}, I_C = 6.4\text{ mA}$		5	5.8	6.5	V
$I_{CES}$	$V_{GE} = 0\text{ V}$ $V_{CE} = 600\text{ V}$	$T_j = 25^\circ\text{C}$	0.15	0.45		$\text{mA}$
		$T_j = 150^\circ\text{C}$				$\text{mA}$
$C_{ies}$				24.7		nF
$C_{oes}$	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$		1.54		nF
$C_{res}$		$f = 1\text{ MHz}$		0.73		nF
$Q_G$	$V_{GE} = -8\text{ V...}+15\text{ V}$			3200		nC
$R_{Gint}$	$T_j = 25^\circ\text{C}$			1.00		$\Omega$
$t_{d(on)}$	$V_{CC} = 300\text{ V}$			150		ns
$t_r$	$I_C = 400\text{ A}$			125		ns
$E_{on}$	$T_j = 150^\circ\text{C}$			22		mJ
$t_{d(off)}$	$R_{G on} = 4.5\ \Omega$ $R_{G off} = 4.5\ \Omega$			900		ns
$t_f$				65		ns
$E_{off}$				24		mJ
$R_{th(j-c)}$	per IGBT				0.12	K/W
$R_{th(j-s)}$	per IGBT					K/W



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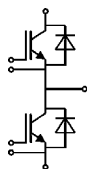
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>Inverse diode</b>						
$V_F = V_{EC}$	$I_F = 400\text{ A}$ $V_{GE} = 0\text{ V}$ chipllevel	$T_j = 25^\circ\text{C}$		1.4	1.6	V
		$T_j = 150^\circ\text{C}$		1.4	1.6	V
$V_{F0}$		$T_j = 25^\circ\text{C}$	0.9	1	1.1	V
		$T_j = 150^\circ\text{C}$	0.75	0.85	0.95	V
$r_F$		$T_j = 25^\circ\text{C}$	0.8	1.0	1.3	m $\Omega$
		$T_j = 150^\circ\text{C}$	1.1	1.4	1.6	m $\Omega$
$I_{RRM}$	$I_F = 400\text{ A}$	$T_j = 150^\circ\text{C}$		250		A
$Q_{rr}$	$di/dt_{off} = 3700\text{ A}/\mu\text{s}$ $V_{GE} = -8\text{ V}$	$T_j = 150^\circ\text{C}$		47		$\mu\text{C}$
$E_{rr}$	$V_{CC} = 300\text{ V}$	$T_j = 150^\circ\text{C}$		10		mJ
$R_{th(j-c)}$	per diode				0.15	K/W
$R_{th(j-s)}$	per diode					K/W
<b>Module</b>						
$L_{CE}$				18		nH
$R_{CC+EE'}$	res., terminal-chip	$T_C = 25^\circ\text{C}$		0.7		m $\Omega$
		$T_C = 125^\circ\text{C}$		1		m $\Omega$
$R_{th(c-s)}$	per module			0.045		K/W
$M_s$	to heat sink (M5)		3		5	Nm
$M_t$		to terminals (M6)	2.5		5	Nm
						Nm
$w$					250	g
<b>Temperature sensor</b>						
$R_{100}$	$T_C=100^\circ\text{C}$ ( $R_{25}=5\text{ k}\Omega$ )			0,493 $\pm 5\%$		k $\Omega$
$B_{100/125}$	$R_{(T)}=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]$ ; $T[\text{K}]$ ;			3550 $\pm 2\%$		K

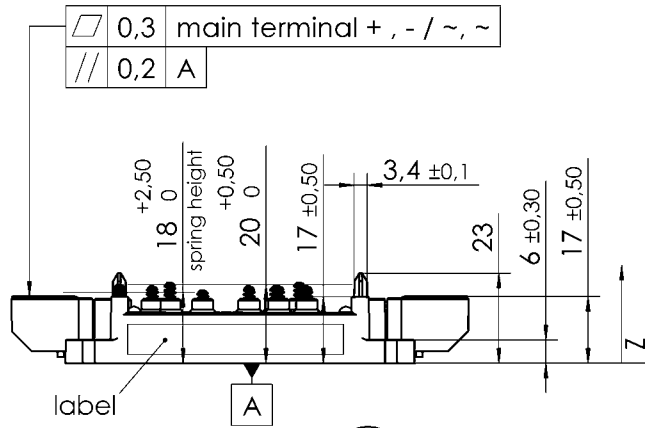
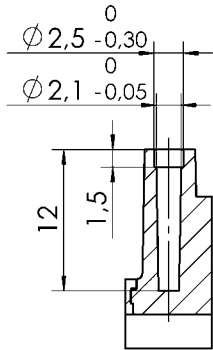


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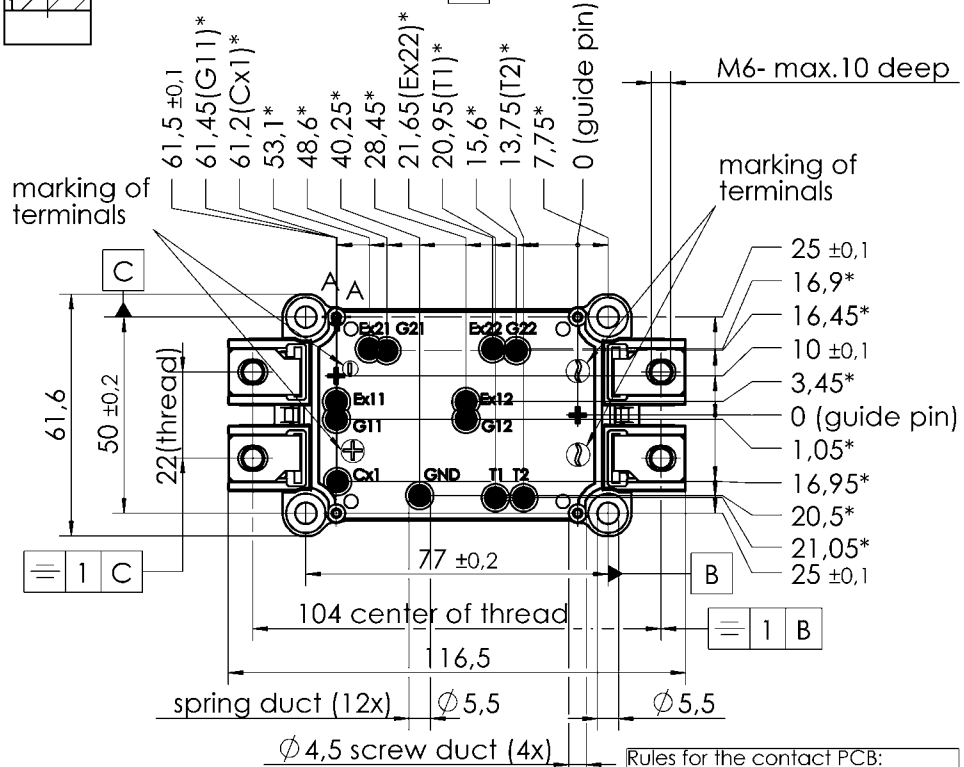
# SEMiX402GB066HDs

case: SEMiX 2s

screw duct (4x):  
A-A (2 : 1)



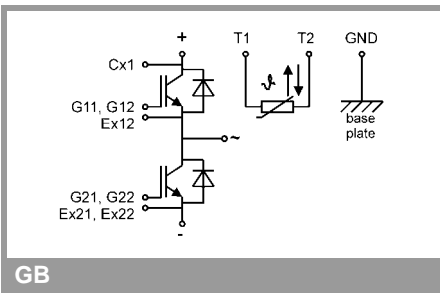
All measures in Z-direction valid as mounted to heat sink



\* all measures with  $\pm 0,2$  B C

Rules for the contact PCB:  
- holes guidepins =  $\varnothing 4 \pm 0,1$   
- spring landing pad =  $\varnothing 3,5 \pm 0,2$

SEMiX 2s



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

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